

N-channel 40 V, 1.6 mΩ, 160 A, D<sup>2</sup>PAK, I<sup>2</sup>PAK  
STripFET™ III Power MOSFET

## Features

Type	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	P <sub>TOT</sub>
STB270N4F3	40 V	< 2.0 mΩ	160 A	330 W
STI270N4F3	40 V	< 2.6 mΩ	120 A	330 W

- 100% avalanche tested
- Standard threshold drive

## Applications

- High current, switching application
  - Automotive

## Description

This STripFET™ III Power MOSFET technology is among the latest improvements, which have been especially tailored to minimize on-state resistance providing superior switching performances.

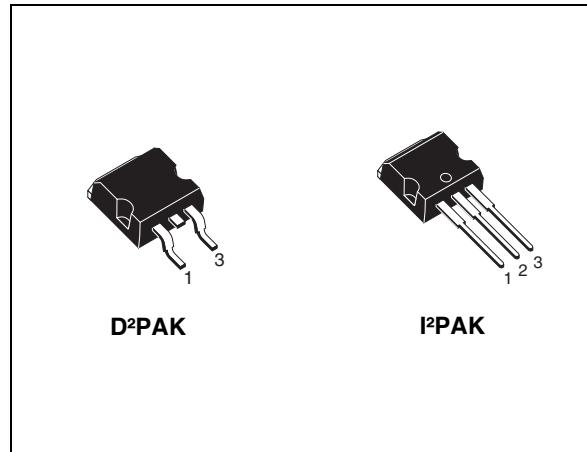


Figure 1. Internal schematic diagram

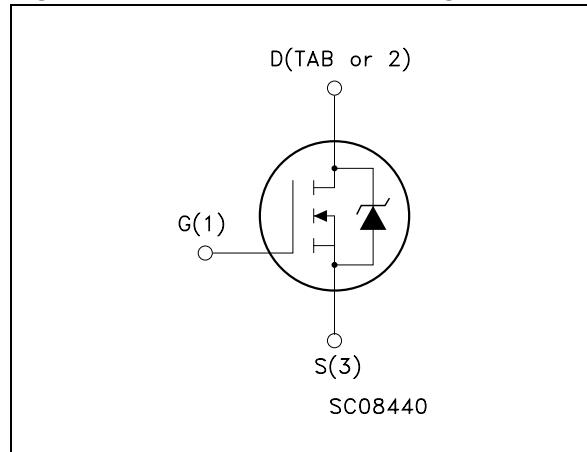


Table 1. Device summary

Order codes	Marking	Package	Packaging
STB270N4F3	270N4F3	D <sup>2</sup> PAK	Tape and reel
STI270N4F3	270N4F3	I <sup>2</sup> PAK	Tube

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value		Unit
		I <sup>2</sup> PAK	D <sup>2</sup> PAK	
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	40		V
V <sub>GS</sub>	Gate-source voltage	± 20		V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	120	160	A
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> =100 °C	120	160	A
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	480	640	A
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	330		W
	Derating factor	2.2		W/°C
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	3.5		V/n
E <sub>AS</sub> <sup>(4)</sup>	Single pulse avalanche energy	1		J
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 175		°C

1. Current limited by package
2. Pulse width limited by safe operating area
3. I<sub>SD</sub> ≤ 120 A, di/dt ≤ 200 A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>j</sub> ≤ T<sub>JMAX</sub>
4. Starting T<sub>j</sub>=25 °C, I<sub>D</sub> =80 A, V<sub>DD</sub>= 32 V

**Table 3. Thermal data**

Symbol	Parameter	Value		Unit
		I <sup>2</sup> PAK	D <sup>2</sup> PAK	
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.45		°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-pcb max		35	°C/W
R <sub>thj-a</sub>	Thermal resistance junction-ambient max	62.5		°C/W
T <sub>I</sub>	Maximum lead temperature for soldering purpose (for 10 sec, 1.6 mm from case)	300		°C

1. When mounted on 1inch<sup>2</sup> FR-4 board, 2 oz Cu.

## 2 Electrical characteristics

( $T_{CASE}=25\text{ }^{\circ}\text{C}$  unless otherwise specified)

**Table 4. On/off states**

Symbol	Parameter	Test conditions		Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 250\text{ }\mu\text{A}, V_{GS} = 0$		40			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max rating}$ , $V_{DS} = \text{Max rating}$ @ $125\text{ }^{\circ}\text{C}$				10 100	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20\text{ V}$				$\pm 200$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$		2		4	V
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 10\text{ V}, I_D = 80\text{ A}$	<b>I<sup>2</sup>PAK</b>		2.1	2.6	mΩ
			<b>D<sup>2</sup>PAK</b>		1.6	2.0	mΩ

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$g_{fs}^{(1)}$	Forward transconductance	$V_{DS} = 15\text{ V}, I_D = 80\text{ A}$	-	200		S
$C_{iss}$ $C_{oss}$ $C_{rss}$	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25\text{ V}, f = 1\text{ MHz}, V_{GS} = 0$	-	7400 1800 47		pF pF pF
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total gate charge Gate-source charge gate-drain charge	$V_{DD} = 20\text{ V}, I_D = 160\text{ A}$ $V_{GS} = 10\text{ V}$ (see Figure 14)	-	110 27 25	150	nC nC nC

1. Pulsed: pulse duration=300μs, duty cycle 1.5%

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_r$	Turn-on delay time Rise time	$V_{DD} = 20\text{ V}, I_D = 80\text{ A},$ $R_G = 4.7\text{ }\Omega, V_{GS} = 10\text{ V}$ (see Figure 16)	-	22 180	-	ns ns
$t_{d(off)}$ $t_f$	Turn-off delay time Fall time	$V_{DD} = 20\text{ V}, I_D = 80\text{ A},$ $R_G = 4.7\text{ }\Omega, V_{GS} = 10\text{ V}$ (see Figure 16)	-	110 45	-	ns ns

**Table 7. Source drain diode**

Symbol	Parameter		Test conditions	Min	Typ.	Max	Unit
$I_{SD}$	Source-drain current	<b>D<sup>2</sup>PAK</b>		-		160	A
		<b>I<sup>2</sup>PAK</b>		-		120	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)	<b>D<sup>2</sup>PAK</b>		-		640	A
		<b>I<sup>2</sup>PAK</b>		-		480	A
$V_{SD}^{(2)}$	Forward on voltage		$I_{SD}=80\text{ A}, V_{GS}=0$	-		1.5	V
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse recovery time Reverse recovery charge Reverse recovery current		$I_{SD}=160\text{ A},$ $di/dt = 100\text{ A}/\mu\text{s},$ $V_{DD}=32\text{ V}, T_j=150\text{ }^\circ\text{C}$ <i>(see Figure 15)</i>	-	70 225 3.2		ns nC A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration=300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

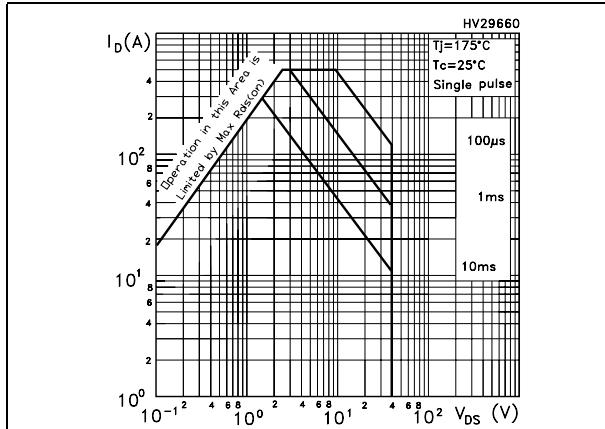


Figure 3. Thermal impedance

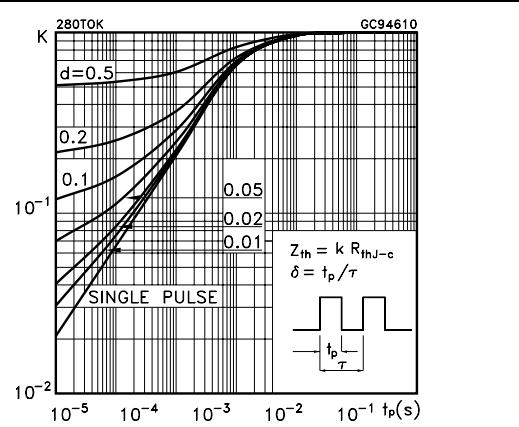


Figure 4. Output characteristics

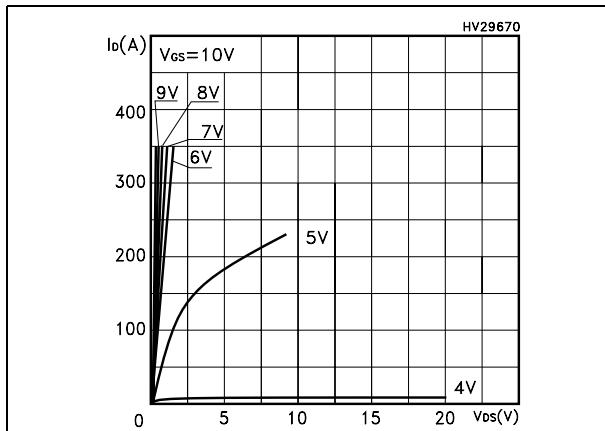


Figure 5. Transfer characteristics

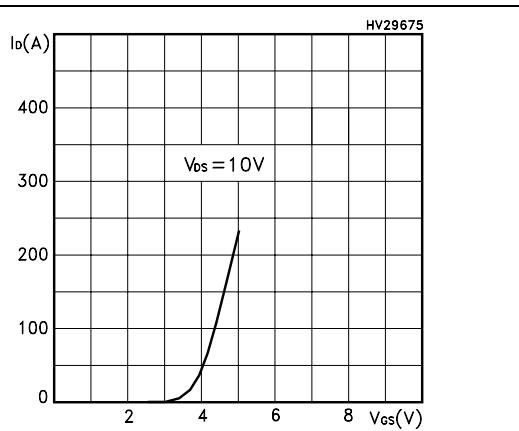
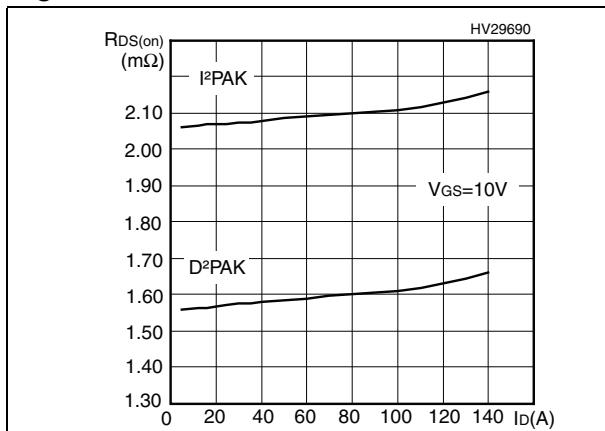
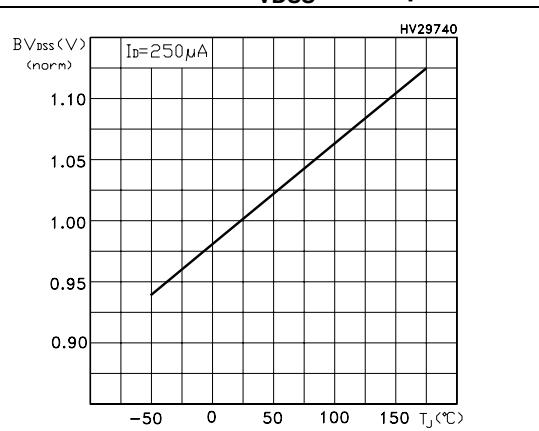
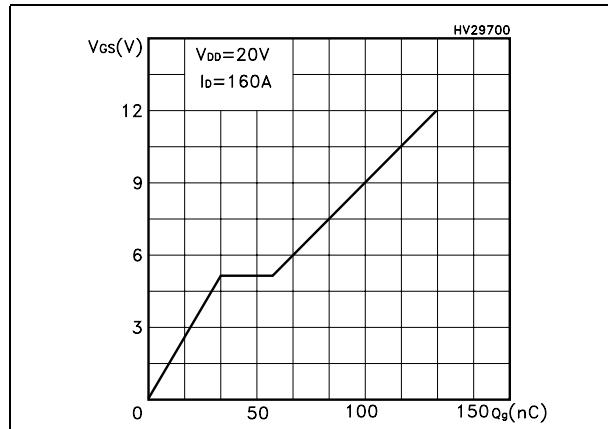
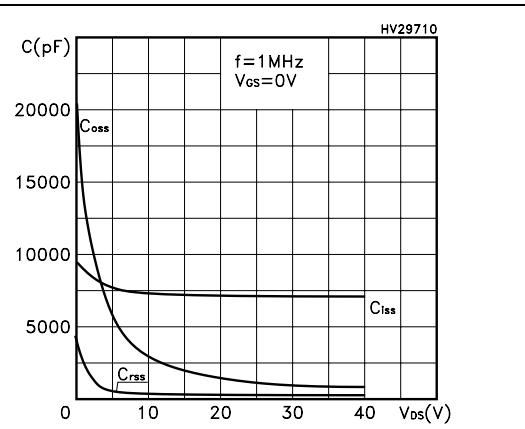
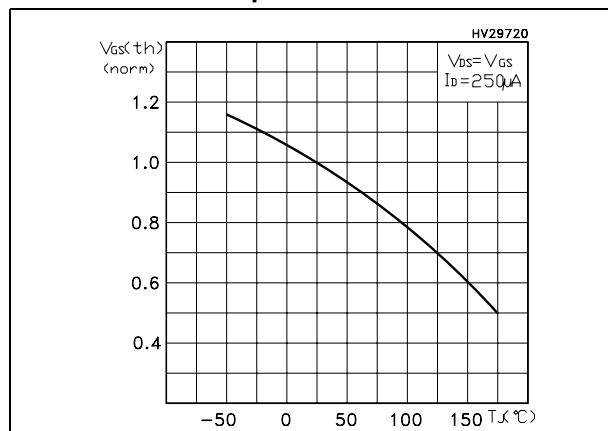
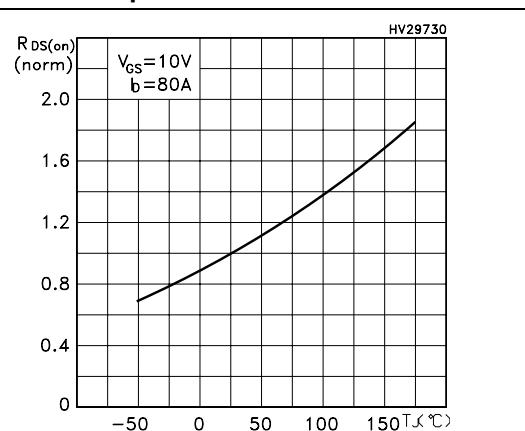
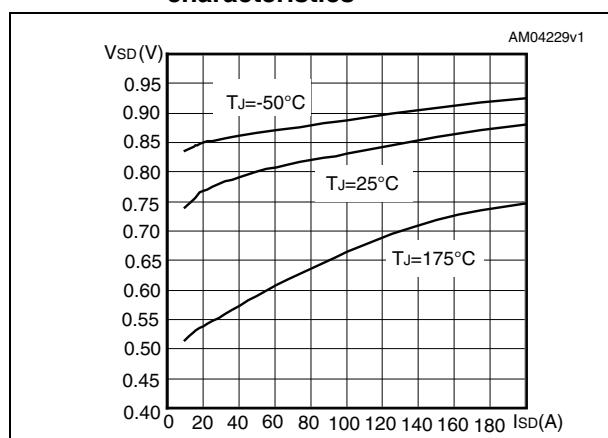


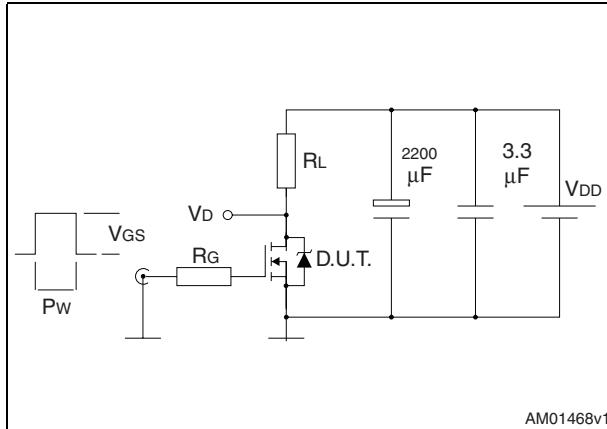
Figure 6. Static drain-source on resistance

Figure 7. Normalized  $B_{VDSS}$  vs temperature

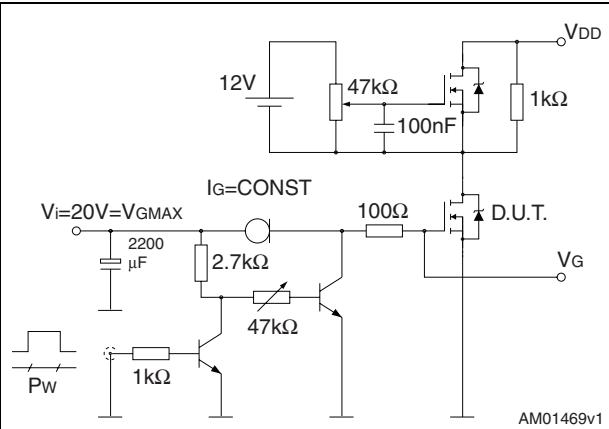
**Figure 8. Gate charge vs gate-source voltage****Figure 9. Capacitance variations****Figure 10. Normalized gate threshold voltage vs temperature****Figure 11. Normalized on resistance vs temperature****Figure 12. Source-drain diode forward characteristics**

### 3 Test circuit

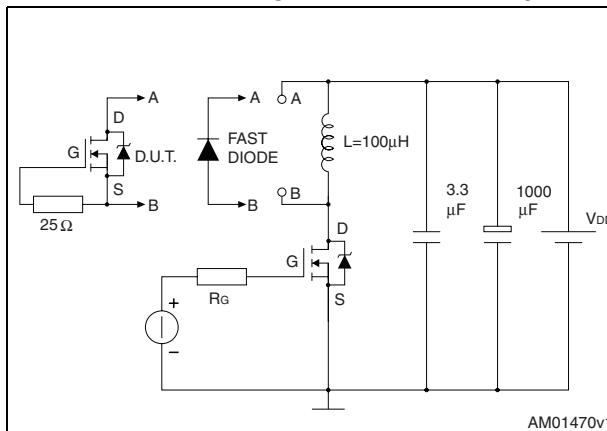
**Figure 13. Switching times test circuit for resistive load**



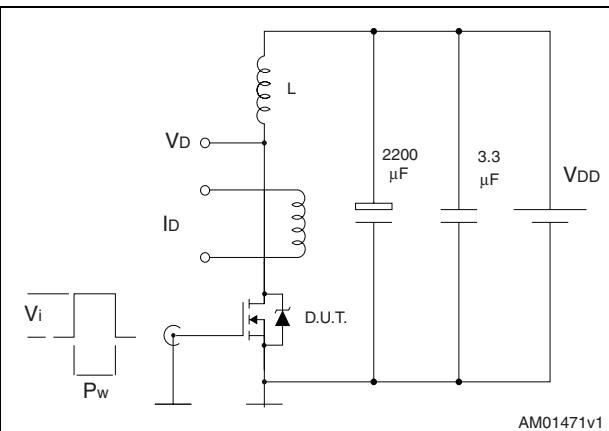
**Figure 14. Gate charge test circuit**



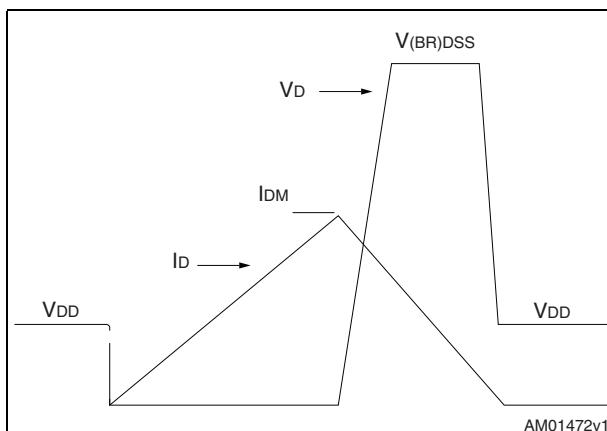
**Figure 15. Test circuit for inductive load switching and diode recovery times**



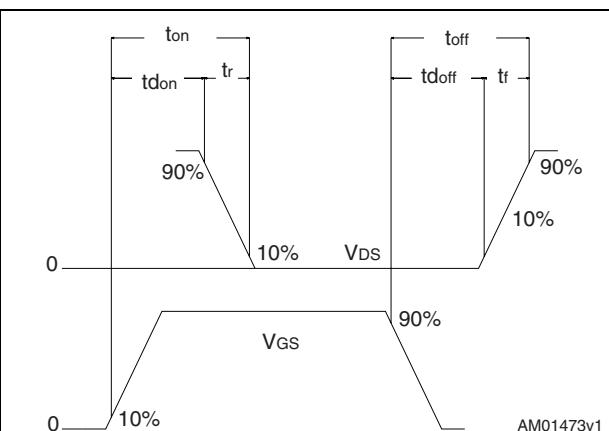
**Figure 16. Unclamped inductive load test circuit**



**Figure 17. Unclamped inductive waveform**



**Figure 18. Switching time waveform**

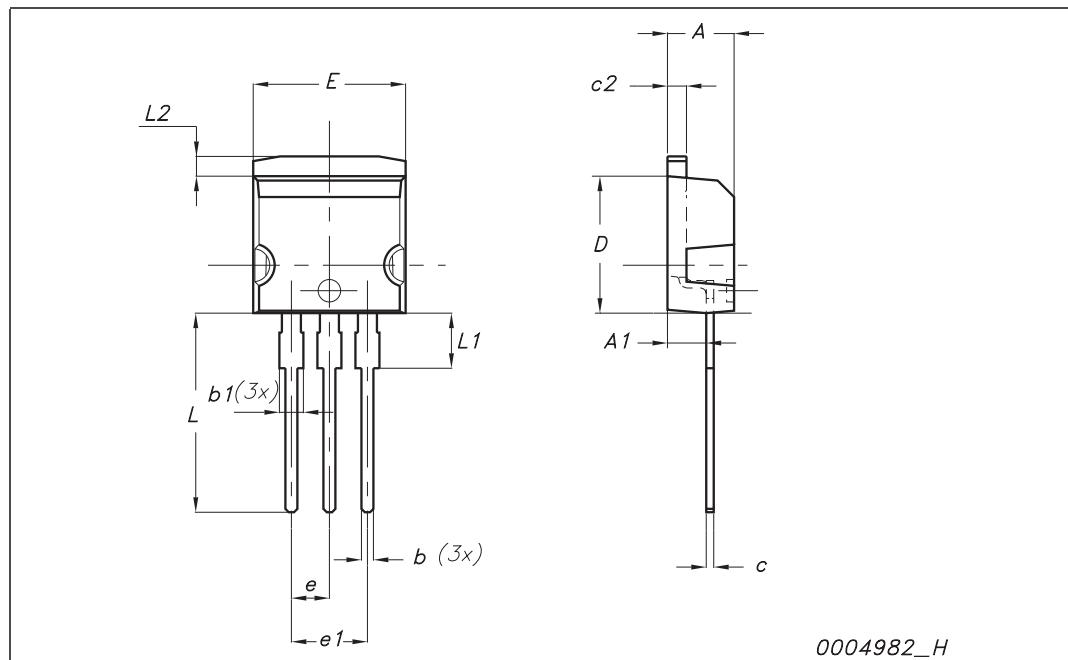


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

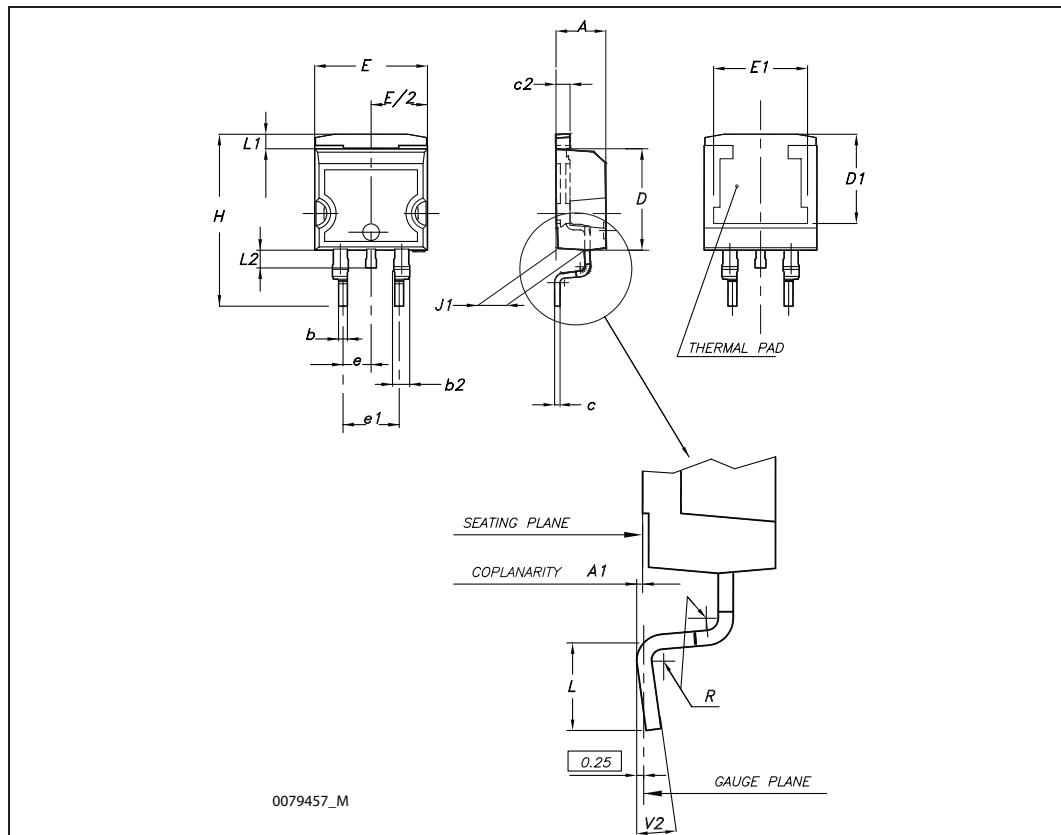
I<sup>2</sup>PAK (TO-262) mechanical data

Dim	mm			inch		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
A1	2.40		2.72	0.094		0.107
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
c	0.49		0.70	0.019		0.027
c2	1.23		1.32	0.048		0.052
D	8.95		9.35	0.352		0.368
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
E	10		10.40	0.393		0.410
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L2	1.27		1.40	0.050		0.055



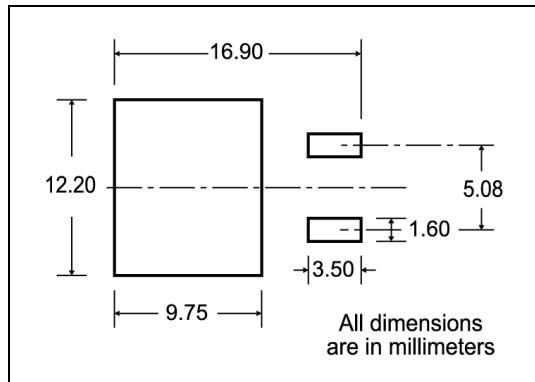
## D<sup>2</sup>PAK (TO-263) mechanical data

Dim	mm			inch		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
A1	0.03		0.23	0.001		0.009
b	0.70		0.93	0.027		0.037
b2	1.14		1.70	0.045		0.067
c	0.45		0.60	0.017		0.024
c2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1	7.50			0.295		
E	10		10.40	0.394		0.409
E1	8.50			0.334		
e		2.54			0.1	
e1	4.88		5.28	0.192		0.208
H	15		15.85	0.590		0.624
J1	2.49		2.69	0.099		0.106
L	2.29		2.79	0.090		0.110
L1	1.27		1.40	0.05		0.055
L2	1.30		1.75	0.051		0.069
R		0.4			0.016	
V2	0°		8°	0°		8°

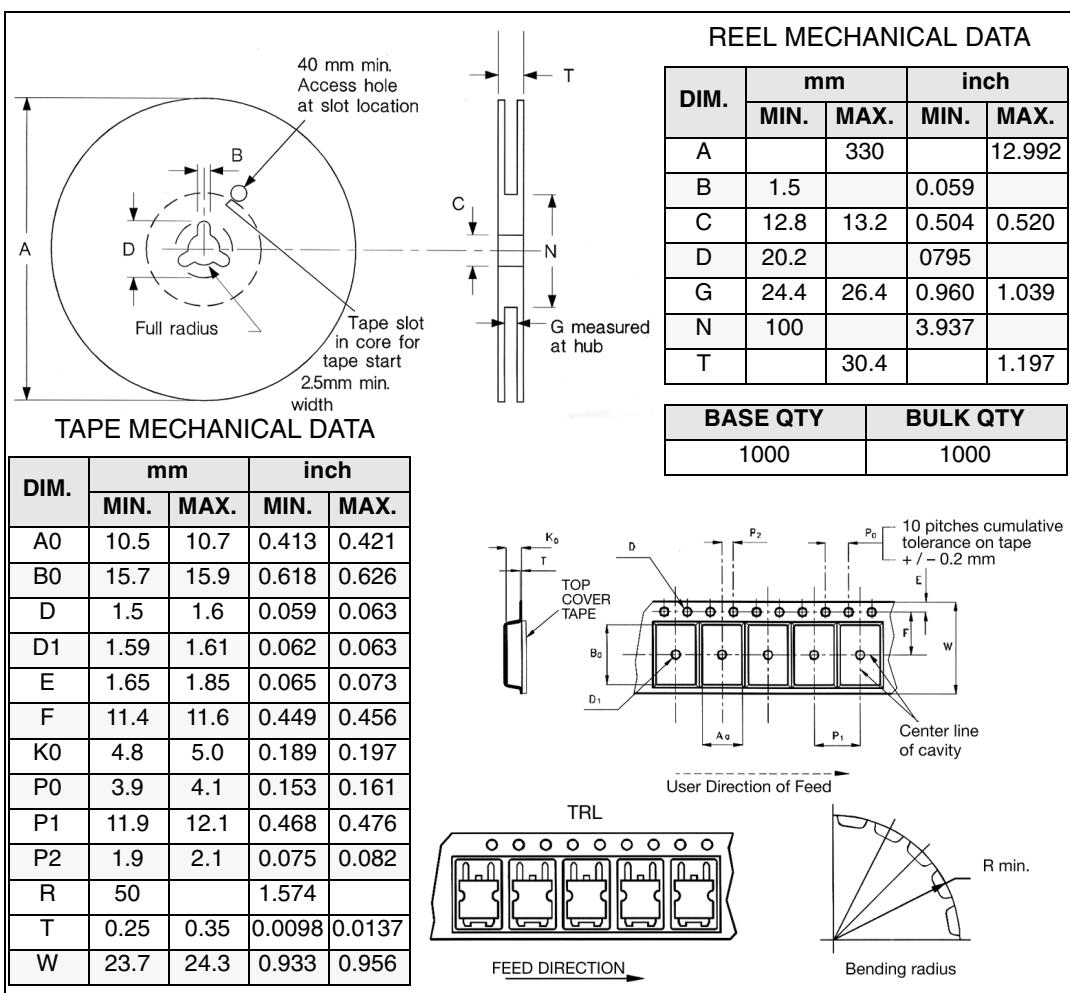


## 5 Packaging mechanical data

### D<sup>2</sup>PAK FOOTPRINT



### TAPE AND REEL SHIPMENT



\* on sales type

## 6 Revision history

**Table 8. Revision history**

Date	Revision	Changes
07-Feb-2007	1	Initial release.
02-Apr-2008	2	Some value changes on <a href="#">Table 2</a>
06-May-2009	3	Changed: <a href="#">Description</a> and <a href="#">Figure 12: Source-drain diode forward characteristics</a>
14-Jul-2009	4	Removed package and mechanical data: TO-220

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